Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/764,376	ITO, FUMIO
Examiner	Art Unit
Rip A. Lee	1713

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Class	Subclass	Date	Examiner
524	148	01-18-223	in
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529	220		
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INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	04-18-2003	n	
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